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<p align="center"><b>Notice of References Cited</b></p>	Application/Control No. 10/058,200	Applicant(s)/Patent Under Reexamination HEITMANN ET AL.	
	Examiner Eugene L Kim	Art Unit 3721	Page 1 of 1

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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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